The Exponential Distribution  

$$X \sim Exp(\lambda)$$
 if pdf is  $f(x) = \begin{cases} \lambda e^{-\lambda x}, x \ge 0 \\ 0, x \ge 0 \end{cases}$   
 $CDF F(x) = \begin{cases} 1 - e^{-\lambda x}, x \ge 0 \\ 0, x \ge 0 \end{cases}$   
 $Remark:$  When studying the life true of an object (e.g. in  
Physics -> decay) we often refer to the "exponential decay  
rak". From a probabilistic point of view we can also  
associate the exponential distribution as a measure of lifegran  
with  $\lambda$  being the failure rate.

Suppose X is the lifespan of some object (e.g. phone battery)  
Lpdf f, CDFF  
Then 
$$P(X \in (t, t+olt) | X > t) = \frac{P(X \in (t, t+dt))}{P(X > t)}$$
  
probability tool if die behaving to oud todat  
grean that it has survived unket.  
 $= \frac{\int_{t}^{t} f(x) dx}{1 - F(t)} \stackrel{dt \approx 0}{\approx} \frac{f(t) dt}{1 - F(t)} = r(t) dt,$   
where  $r(t) = \frac{f(t)}{1 - F(t)}$  is the failure (hazard) rate  
function.  
 $\rightarrow If X \sim Exp(X)$ , then  $r(t) = \frac{\lambda}{e^{-\lambda t}} = \lambda.$   
 $\rightarrow$  So the failure rate function is constant for the  
exponential r.v. (i.e., it doesn't depend on time).

Remark: By the definition of the nomenony property. If a  
r.v. is memory less, its failure rate is constant!  
Prof: 
$$P(X \in (t, t+dt) | X > t) = r(t) dt$$
 for  $dt$  small.  
If  
 $I = P(X \ge t+dt | X > t) = 1 - P(X \ge dt)$  does not  
depend  
neurony less out!  
Remark:  $r(t) = \frac{f(t)}{1 - F(t)} = \frac{F'(t)}{1 - F(t)}$  failure rate uniquely  
 $=> b_n (1 - F(t)) = -\int_0^t r(t) du + C$   
 $\Rightarrow I - F(t) = e^c e^c = > C = 0.$   
 $\Rightarrow F(t) = 1 - exp^{-\int_0^t r(u) du}$   
If  $r$  is constant, then  $F(t) = 1 - e^{-t\lambda}$   
 $r(s) = \lambda.$   
 $\Rightarrow X$  is exponential distribution is the only real  
memory less  $r.V.$ 

The parameter  $\lambda$  is the rate of the distribution. Example:  $X_{1,...,} X_{n}$  independent exponential r.v.'s write respective rates  $\lambda_{1,...,} \lambda_{n}$ ,  $\lambda_{i} \neq \lambda_{j}$ . Suppose that a bin contains n different types of patteries with a type j bottory lasting  $Exp(\lambda_{j})$  time.

Suppose further that 
$$p_j$$
 is the proportion of type;  
Datteries in the bin,  $\sum_{j=1}^{n} p_j = 1$ .  
If a bottom is randomly chosen, what is the  
distribution of the liftime of this bottom?  
 $T \in S_{1,...,n}$   $P(T=j) = f_j$ .  
Battom liftime is the r.v.  $X_T$  "hyperceponential  
random variable".  
To obtain the distribution function of  $X_T$ :  
 $1 - F(H) = \sum_{i=1}^{n} P(X_i > t | T=i) P(T=i)$   
 $= \sum_{i=1}^{n} P_i e^{-\lambda_i t}$ 

To get 
$$f(t)$$
:  
 $f(t) = F'(t) = -(1 - F(t))' = \sum_{i=1}^{n} \lambda_i p_i e^{-\lambda_i t}.$ 

=> The failure rate function is  

$$r(t) = \frac{f(t)}{1-F(t)} = \frac{\sum_{i=1}^{n} \lambda_i p_i e^{-\lambda_i t}}{\sum_{i=1}^{n} p_i e^{-\lambda_i t}}$$

Let  $\lambda_1 < \lambda_2 < \dots < \lambda_n$ . (oupute P(T=1|X>t) as  $t \rightarrow \infty$ .

$$P(T=A|X>t) = \frac{P(X>t|T=A)P(T=A)}{P(X>t)}$$

$$= \frac{P_{1}e^{-\lambda_{1}t}}{\sum_{i=1}^{n}P_{i}e^{-\lambda_{i}t}} = \frac{P_{1}e^{-\lambda_{i}t}}{P_{1}e^{-\lambda_{1}t}} + \sum_{i=2}^{n}P_{i}e^{-\lambda_{i}t}$$

$$= \frac{P_{1}}{P_{1} + \sum_{i=2}^{n} P_{i} e^{-(\lambda_{i} - \lambda_{i})t}} \xrightarrow{-r} \int as t \rightarrow \infty.$$

$$P(T=i| X > t) \rightarrow 0 as t \rightarrow \infty$$
for  $i \ge 1$ 

$$for i \ge 1$$

$$\int P(T=i| X > t) \rightarrow 0 as t \rightarrow \infty$$

$$\int e^{-\lambda_{i}t} + \sum_{i=2}^{n} \lambda_{i} P_{i} e^{-\lambda_{i}t}$$

$$= \lim_{t \to \infty} \frac{\lambda_{i} P_{i} + \sum_{i=2}^{n} \lambda_{i} P_{i} e^{-\lambda_{i}t}}{P_{i} e^{-\lambda_{i}t} + \sum_{i=2}^{n} P_{i} e^{-\lambda_{i}t}} \xrightarrow{-r} \lambda_{i} as t \rightarrow \infty.$$

As the randomly chosen battery ages its failure  
rate converges to the anallest 
$$\lambda_i!$$
  
The longer the battery lasts, the more lindy it is  
a battery type with the smallest failure rate.